## **STB5N80K5**



# N-channel 800 V, 1.50 Ω typ., 4 A MDmesh™ K5 Power MOSFET in a D²PAK package

Datasheet - production data

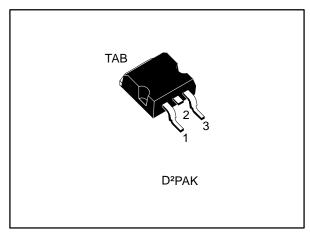
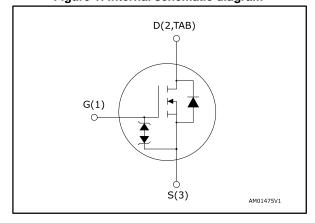


Figure 1: Internal schematic diagram



### **Features**

| Order code | V <sub>DS</sub> | R <sub>DS(on)</sub> max. | ΙD  |  |
|------------|-----------------|--------------------------|-----|--|
| STB5N80K5  | 800 V           | 1.75 Ω                   | 4 A |  |

- Industry's lowest R<sub>DS(on)</sub> x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

### **Applications**

• Switching applications

### **Description**

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

**Table 1: Device summary** 

| Order code | Marking | Package | Packing       |
|------------|---------|---------|---------------|
| STB5N80K5  | 5N80K5  | D²PAK   | Tape and reel |

Contents STB5N80K5

## Contents

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STB5N80K5 Electrical ratings

# 1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol                        | Parameter   | Value       | Unit   |
|-------------------------------|---|-------------|--------|
| V <sub>G</sub> s              | Gate-source voltage                                   | ± 30        | V      |
| $I_D$                         | Drain current (continuous) at T <sub>C</sub> = 25 °C  | 4           | Α      |
| ΙD                            | Drain current (continuous) at T <sub>C</sub> = 100 °C | 2.3         | Α      |
| I <sub>D</sub> <sup>(1)</sup> | Drain current (pulsed)                                | 16          | Α      |
| P <sub>TOT</sub>              | Total dissipation at T <sub>C</sub> = 25 °C           | 60          | W      |
| dv/dt (2)                     | Peak diode recovery voltage slope                     | 4.5         | \//n a |
| dv/dt (3)                     | dt (3) MOSFET dv/dt ruggedness                        |             | V/ns   |
| Tj                            | Operating junction temperature range                  | FF to 150   |        |
| T <sub>stg</sub>              | Storage temperature range                             | - 55 to 150 | °C     |

### Notes:

Table 3: Thermal data

| Symbol                              | Parameter                        | Value | Unit |
|-------------------------------------|----------------------------------|-------|------|
| R <sub>thj-case</sub>               | Thermal resistance junction-case | 2.08  | °C/W |
| R <sub>thj-pcb</sub> <sup>(1)</sup> | Thermal resistance junction-pcb  | 35    | °C/W |

#### Notes

**Table 4: Avalanche characteristics** 

| Symbol          | nbol Parameter   |  | Unit |
|-----------------|--|--|------|
| I <sub>AR</sub> | I <sub>AR</sub> Avalanche current, repetitive or not repetitive (pulse width limited by Tjmax)                                 |  | A    |
| Eas             | E <sub>AS</sub> Single pulse avalanche energy (starting Tj = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V) |  | mJ   |

<sup>&</sup>lt;sup>(1)</sup>Pulse width limited by safe operating area

 $<sup>^{(2)}</sup>I_{SD} \leq 4$  A, di/dt =100 A/ $\mu$ s; VDS peak < V(BR)DSS, VDD=640 V

 $<sup>^{(3)}</sup>V_{DS} \le 640 \text{ V}$ 

 $<sup>^{(1)}</sup>$ When mounted on FR-4 board of 1 inch², 2 oz Cu

Electrical characteristics STB5N80K5

### 2 Electrical characteristics

T<sub>C</sub> = 25 °C unless otherwise specified

Table 5: On/off-state

| Symbol               | Parameter                         | Test conditions   | Min. | Тур. | Max. | Unit |
|----------------------|-----------------------------------|---|------|------|------|------|
| V <sub>(BR)DSS</sub> | Drain-source breakdown voltage    | $V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$                                    | 800  |      |      | V    |
|                      |                                   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 800 V                                |      |      | 1    | μΑ   |
| I <sub>DSS</sub>     | Zero gate voltage drain current   | $V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$ $T_{C} = 125 \text{ °C}^{(1)}$ |      |      | 50   | μΑ   |
| I <sub>GSS</sub>     | Gate body leakage current         | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                             |      |      | ±10  | μΑ   |
| V <sub>GS(th)</sub>  | Gate threshold voltage            | $V_{DD} = V_{GS}$ , $I_D = 100 \mu A$   | 3    | 4    | 5    | V    |
| R <sub>DS(on)</sub>  | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 2 \text{ A}$                                    |      | 1.50 | 1.75 | Ω    |

#### Notes:

Table 6: Dynamic

| Symbol                            | Parameter                             | Test conditions  | Min. | Тур. | Max. | Unit |
|-----------------------------------|---------------------------------------|--|------|------|------|------|
| Ciss                              | Input capacitance                     |  | 1    | 177  | -    | pF   |
| Coss                              | Output capacitance                    | $V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$<br>$V_{GS} = 0 \text{ V}$ | 1    | 15   | -    | pF   |
| Crss                              | Reverse transfer capacitance          |  | ı    | 0.3  | -    | pF   |
| C <sub>o(tr)</sub> <sup>(1)</sup> | Equivalent capacitance time related   | V 0 V 0 to 640 V   | ı    | 33   | -    | pF   |
| C <sub>o(er)</sub> <sup>(2)</sup> | Equivalent capacitance energy related | $V_{GS} = 0$ , $V_{DS} = 0$ to 640 V                                   |      | 12   |      | pF   |
| Rg                                | Intrinsic gate resistance             | f = 1 MHz , I <sub>D</sub> = 0 A                                       | •    | 16   | -    | Ω    |
| Qg                                | Total gate charge                     | V <sub>DD</sub> = 640 V, I <sub>D</sub> = 4 A                          | -    | 5    | -    | nC   |
| Q <sub>gs</sub>                   | Gate-source charge                    | V <sub>GS</sub> = 10 V   | 1    | 1.7  | -    | nC   |
| Q <sub>gd</sub>                   | Gate-drain charge                     | (see Figure 15: "Test circuit for gate charge behavior")               | -    | 2.9  | -    | nC   |

### Notes:

<sup>&</sup>lt;sup>(1)</sup>Defined by design, not subject to production test.

 $<sup>^{(1)}</sup>$ Co(tr) is a constant capacitance value that gives the same charging time as Coss while Vps is rising from 0 to 80% Vpss.

 $<sup>^{(2)}</sup>$ Co<sub>(er)</sub> is a constant capacitance value that gives the same stored energy as Coss while VDs is rising from 0 to 80% VDss.

Table 7: Switching times

| Symbol              | Parameter           | Test conditions   | Min. | Тур. | Max. | Unit |
|---------------------|---------------------|---|------|------|------|------|
| t <sub>d(on)</sub>  | Turn-on delay time  | $V_{DD}$ = 400 V, $I_{D}$ = 2 A, $R_{G}$ = 4.7 $\Omega$           | ı    | 12.7 | 1    | ns   |
| tr                  | Rise time           | V <sub>GS</sub> = 10 V  | ı    | 11.7 | 1    | ns   |
| t <sub>d(off)</sub> | Turn-off delay time | (see Figure 14: "Test circuit for resistive load switching times" | -    | 23   | -    | ns   |
| t <sub>f</sub>      | Fall time           | and Figure 19: "Switching time waveform")                         | -    | 14.8 | -    | ns   |

Table 8: Source-drain diode

| Symbol                          | Parameter                     | Test conditions  | Min. | Тур. | Max. | Unit |
|---------------------------------|-------------------------------|--|------|------|------|------|
| I <sub>SD</sub>                 | Source-drain current          |  | -    |      | 4    | Α    |
| I <sub>SDM</sub> <sup>(1)</sup> | Source-drain current (pulsed) |  | -    |      | 16   | Α    |
| V <sub>SD</sub> <sup>(2)</sup>  | Forward on voltage            | I <sub>SD</sub> = 4 A, V <sub>GS</sub> = 0 V   | -    |      | 1.5  | V    |
| t <sub>rr</sub>                 | Reverse recovery time         | $I_{SD} = 4 \text{ A}, \text{ di/dt} = 100$  | -    | 265  |      | ns   |
| Qrr                             | Reverse recovery charge       | A/µs,V <sub>DD</sub> = 60 V<br>(see Figure 16: "Test circuit<br>for inductive load switching<br>and diode recovery times")                     | -    | 1.59 |      | μC   |
| I <sub>RRM</sub>                | Reverse recovery current      |  | -    | 12   |      | Α    |
| t <sub>rr</sub>                 | Reverse recovery time         | $I_{SD} = 4 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$  | -    | 386  |      | ns   |
| Qrr                             | Reverse recovery charge       | V <sub>DD</sub> = 60 V, T <sub>j</sub> = 150 °C<br>(see Figure 16: "Test circuit<br>for inductive load switching<br>and diode recovery times") | -    | 2.18 |      | μC   |
| I <sub>RRM</sub>                | Reverse recovery current      |  | -    | 11.3 |      | Α    |

#### Notes:

Table 9: Gate-source Zener diode

| Symbol               | Parameter                     | Test conditions                               | Min. | Тур. | Max. | Unit |
|----------------------|-------------------------------|---|------|------|------|------|
| V <sub>(BR)GSO</sub> | Gate-source breakdown voltage | I <sub>GS</sub> = ± 1mA, I <sub>D</sub> = 0 A | 30   | -    | 1    | V    |

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



<sup>&</sup>lt;sup>(1)</sup>Pulse width limited by safe operating area

 $<sup>^{(2)}</sup>$ Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2: Safe operating area (A) Operation in this area is limited by R<sub>DS(On)</sub> GIPG280420161139SOA 10 t<sub>o</sub>=10 μs t₀=100 µs 10<sup>0</sup> t\_=1 ms t₀=10 ms T<sub>i</sub>≤150 °C 10 T<sub>o</sub>= 25°C single pulse 10<sup>-2</sup>  $\overline{V}_{DS}(V)$ 10<sup>1</sup> 10<sup>2</sup>

Figure 3: Thermal impedance  $K \\ \delta = 0.5$   $\delta = 0.2$   $\delta = 0.1$   $\delta = 0.05$   $\delta = 0.05$   $\delta = 0.05$   $\delta = 0.02$   $\delta = 0.01$  SINGLE PULSE  $10^{-2}$   $10^{-5}$   $10^{-4}$   $10^{-3}$   $10^{-2}$   $10^{-1}$   $t_p(s)$ 

Figure 4: Output characteristics

ID GIPG2104201615280CH

(A) V<sub>GS</sub>=11 V

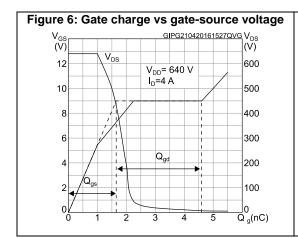
5 V<sub>GS</sub>=9 V

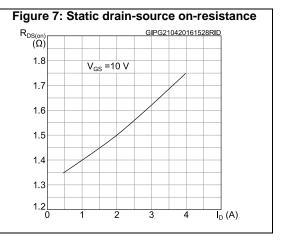
4 V<sub>GS</sub>=8 V

2 V<sub>GS</sub>=7 V

1 V<sub>GS</sub>=6 V

0 4 8 12 16 V<sub>DS</sub> (V)





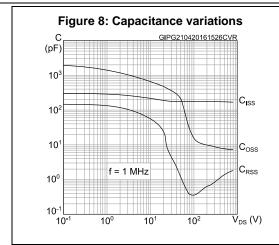


Figure 10: Normalized on-resistance vs temperature

R<sub>DS(on)</sub> GIPG210420161531RON
(norm.)

2.6 V<sub>GS</sub> = 10 V

2.2

1.8

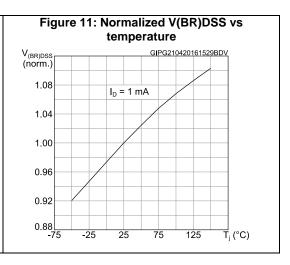
1.4

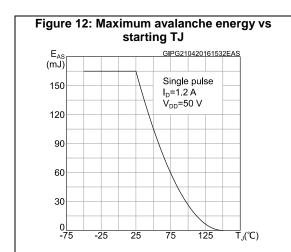
1.0

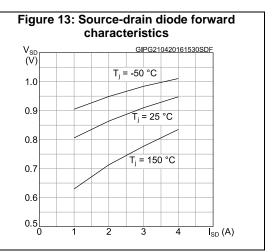
0.6

0.2

-75 -25 25 75 125 T<sub>j</sub> (°C)







Test circuits STB5N80K5

### 3 Test circuits

Figure 14: Test circuit for resistive load switching times

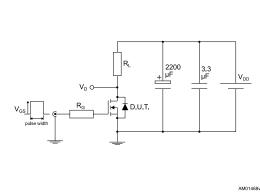


Figure 15: Test circuit for gate charge behavior

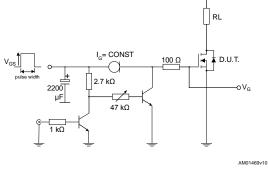


Figure 16: Test circuit for inductive load switching and diode recovery times

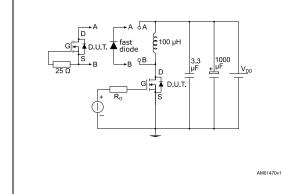


Figure 17: Unclamped inductive load test circuit

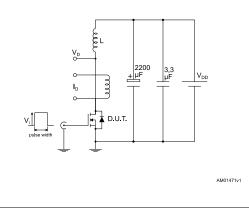


Figure 18: Unclamped inductive waveform

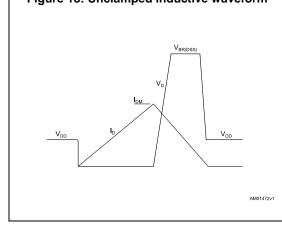
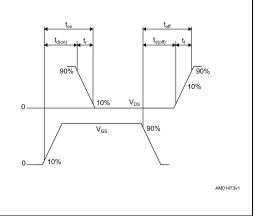


Figure 19: Switching time waveform



STB5N80K5 Package information

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

### 4.1 D<sup>2</sup>PAK (TO-263) type A package information

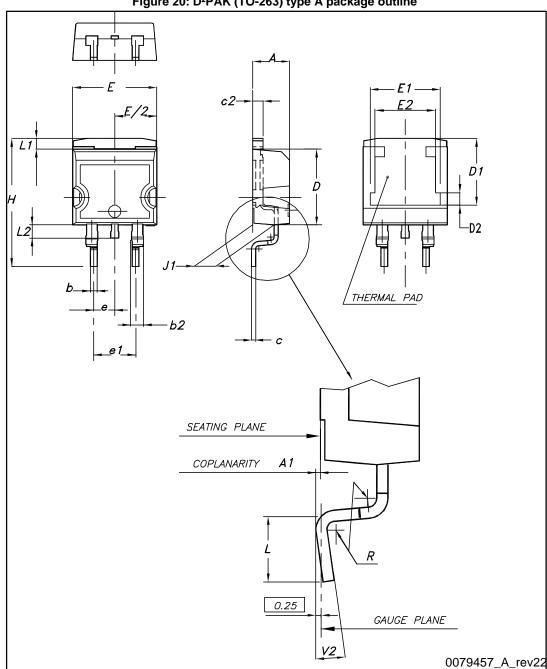


Figure 20: D<sup>2</sup>PAK (TO-263) type A package outline

Table 10: D<sup>2</sup>PAK (TO-263) type A package mechanical data

|      |      | mm   |       |
|------|------|------|-------|
| Dim. | Min. | Тур. | Max.  |
| А    | 4.40 |      | 4.60  |
| A1   | 0.03 |      | 0.23  |
| b    | 0.70 |      | 0.93  |
| b2   | 1.14 |      | 1.70  |
| С    | 0.45 |      | 0.60  |
| c2   | 1.23 |      | 1.36  |
| D    | 8.95 |      | 9.35  |
| D1   | 7.50 | 7.75 | 8.00  |
| D2   | 1.10 | 1.30 | 1.50  |
| Е    | 10   |      | 10.40 |
| E1   | 8.50 | 8.70 | 8.90  |
| E2   | 6.85 | 7.05 | 7.25  |
| е    |      | 2.54 |       |
| e1   | 4.88 |      | 5.28  |
| Н    | 15   |      | 15.85 |
| J1   | 2.49 |      | 2.69  |
| L    | 2.29 |      | 2.79  |
| L1   | 1.27 |      | 1.40  |
| L2   | 1.30 |      | 1.75  |
| R    |      | 0.4  |       |
| V2   | 0°   |      | 8°    |

STB5N80K5 Package information

9.75 16.9 1.6 2.54

Figure 21: D<sup>2</sup>PAK (TO-263) recommended footprint (dimensions are in mm)

Footprint

## 4.2 Packing information

Figure 22: Tape outline

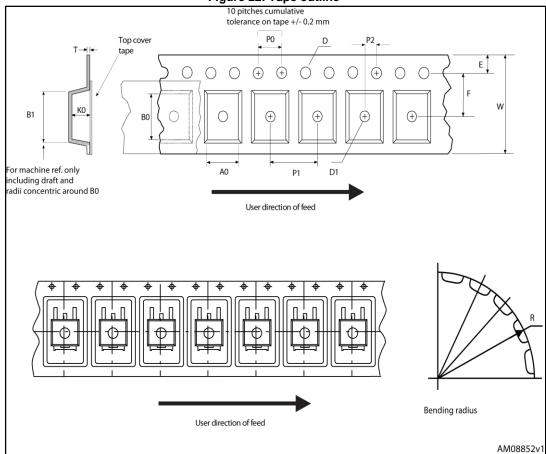


Figure 23: Reel outline

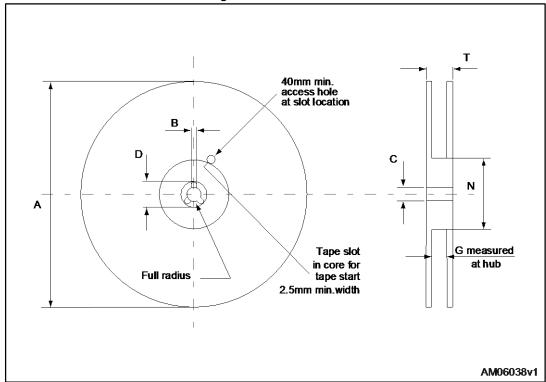


Table 11: D2PAK tape and reel mechanical data

| Таре |      |      | Reel               |      |      |
|------|------|------|--------------------|------|------|
| Dim. | mm   |      | Dim                | mm   |      |
|      | Min. | Max. | Dim.               | Min. | Max. |
| A0   | 10.5 | 10.7 | А                  |      | 330  |
| В0   | 15.7 | 15.9 | В                  | 1.5  |      |
| D    | 1.5  | 1.6  | С                  | 12.8 | 13.2 |
| D1   | 1.59 | 1.61 | D                  | 20.2 |      |
| E    | 1.65 | 1.85 | G                  | 24.4 | 26.4 |
| F    | 11.4 | 11.6 | N                  | 100  |      |
| K0   | 4.8  | 5.0  | Т                  |      | 30.4 |
| P0   | 3.9  | 4.1  |                    |      |      |
| P1   | 11.9 | 12.1 | Base quantity 1000 |      | 1000 |
| P2   | 1.9  | 2.1  | Bulk quantity 1000 |      | 1000 |
| R    | 50   |      |                    |      |      |
| Т    | 0.25 | 0.35 |                    |      |      |
| W    | 23.7 | 24.3 |                    |      |      |

Revision history STB5N80K5

# 5 Revision history

Table 12: Document revision history

| Date        | Revision | Changes  |
|-------------|----------|--|
| 19-Nov-2015 | 1        | First release.   |
| 09-May-2016 | 2        | Modified: Table 2: "Absolute maximum ratings", Table 3: "Thermal data", Table 5: "On/off-state", Table 6: "Dynamic", Table 7: "Switching times" and Table 8: "Source-drain diode"  Updated: Section 4: "Test circuits"  Added: Section 3.1: "Electrical characteristics (curves)"  Minor text changes. |

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